Power MOSFET

24 A, 60 V Single N-Channel DPAK

Features

- Low R_{DS(on)}
- High Current Capability
- Avalanche Energy Specified
- NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Applications

- LED Lighting and LED Backlight Drivers
- DC-DC Converters
- DC Motor Drivers
- Power Supplies Secondary Side Synchronous Rectification

MAXIMUM RATINGS (T_J = 25°C Unless otherwise specified)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	60	V
Gate-to-Source Voltage	Gate-to-Source Voltage - Continuous			±20	V
Gate-to-Source Voltage – Nonrepetitive (Tp < 10 µs)			V _{GS}	± 30	V
Continuous Drain Current R _{0JC}	Steady State	T _C = 25°C	I _D	24	Α
(Note 1)	State	T _C = 100°C		16	
Power Dissipation R _{0JC} (Note 1)	Steady State	T _C = 25°C	P _D	55	W
Pulsed Drain Current	t _p = 10 μs		I _{DM}	75	Α
Operating and Storage Temperature Range			T _J , T _{stg}	–55 to +175	°C
Source Current (Body Diode)			IS	24	Α
Single Pulse Drain–to–Source Avalanche Energy – Starting $T_J = 25^{\circ}C$ ($V_{DD} = 50 \ V_{dc}, \ V_{GS} = 10 \ V, \ I_{L(pk)} = 24 \ A, L = 0.3 \ mH, \ R_G = 25 \ \Omega$)			E _{AS}	86.4	mJ
Lead Temperature for Soldering Purposes, 1/8" from Case for 10 Seconds			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain) Steady State (Note 1)	$R_{\theta JC}$	2.7	°C/W
(Note 1)	$R_{\theta JA}$	58.6	

 Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [1 oz] including traces).

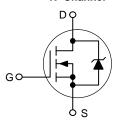


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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX (Note 1)
60 V	37 mΩ @ 10 V	24 A

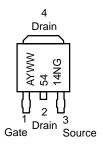
N-Channel





MARKING DIAGRAMS & PIN ASSIGNMENT

STYLE 2



A = Assembly Location*

Y = Year WW = Work Week

5414N = Specific Device Code G = Pb-Free Device

* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25$ °C Unless otherwise specified)

Characteristics	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				-	-	-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{DS} = 0 V$,	I _D = 250 μA	60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				67.3		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V	T _J = 25°C			1.0	μΑ
		$V_{DS} = 60 \text{ V}$	T _J = 150°C			50	1
Gate-Body Leakage Current	I _{GSS}	V _{DS} = 0 V, V	_{GS} = ±20 V			±100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V _{GS(th)}	$V_{GS} = V_{DS}$	I _D = 250 μA	2.0	3.2	4.0	V
Negative Threshold Temperature Coefficient	V _{GS(th)} /T _J				0.74		mV/°C
Drain-to-Source On-Voltage	V _{DS(on)}	V _{GS} = 10 \	/, I _D = 24 A		0.7	1.16	V
		$V_{GS} = 10 \text{ V, } I_{D}$	= 12 A, 150°C		0.7		1
Drain-to-Source On-Resistance	R _{DS(on)}	V _{GS} = 10 \	/, I _D = 24 A		28.4	37	mΩ
Forward Transconductance	9FS	V _{DS} = 15 V, I _D = 20 A			24		S
CHARGES, CAPACITANCES & GATE RESIST.	ANCE				•	-	-
Input Capacitance	C _{iss}	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz			800	1200	pF
Output Capacitance	C _{oss}				165		1 !
Transfer Capacitance	C _{rss}				75		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 48 V,			25	48	nC
Threshold Gate Charge	Q _{G(TH)}	I _D =	24 A		1.1		1
Gate-to-Source Charge	Q _{GS}				4.8		1
Gate-to-Drain Charge	Q_{GD}	1			11.3		1
SWITCHING CHARACTERISTICS, V _{GS} = 10 V	(Note 3)						
Turn-On Delay Time	t _{d(on)}	$V_{GS} = 10 \text{ V},$	V _{DD} = 48 V,		12		ns
Rise Time	t _r	$I_D = 24 A,$	$R_G = 9.1 \Omega$		58		1
Turn-Off Delay Time	t _{d(off)}				47		1
Fall Time	t _f				69		1
DRAIN-SOURCE DIODE CHARACTERISTICS							
Forward Diode Voltage (Note 2)	V _{SD}	V _{GS} = 0 V	T _J = 25°C		0.92	1.15	V
		$I_S = 24 A$	T _J = 125°C		0.8		1
Reverse Recovery Time	t _{rr}	$I_S = 24 A_{dc}$	$V_{GS} = 0 V_{dc}$		45.7		ns
Charge Time	t _a	$dI_S/dt = 100 A/\mu s$			31.7		1
Discharge Time	t _b				14		1
Reverse Recovery Stored Charge	Q_{RR}				76		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. Pulse Test: Pulse Width $\leq 300~\mu$ s, Duty Cycle $\leq 2\%$.

3. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

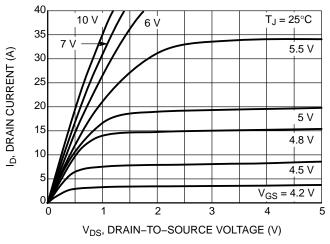


Figure 1. On-Region Characteristics

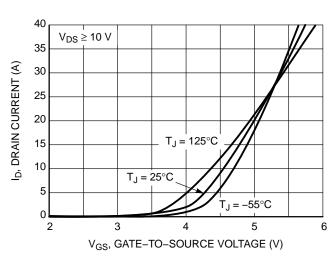


Figure 2. Transfer Characteristics

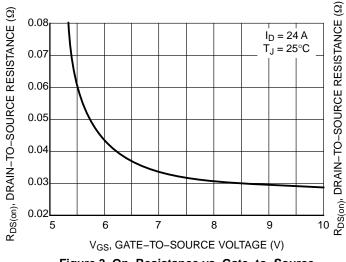


Figure 3. On-Resistance vs. Gate-to-Source Voltage

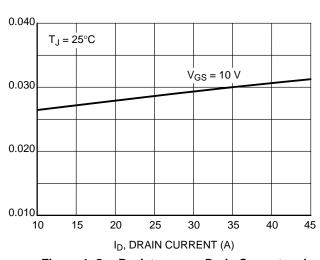


Figure 4. On-Resistance vs. Drain Current and **Gate Voltage**

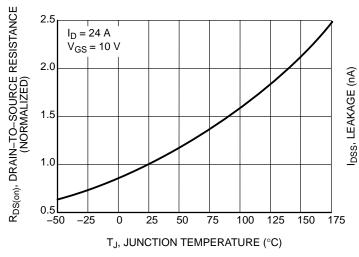


Figure 5. On-Resistance Variation with **Temperature**

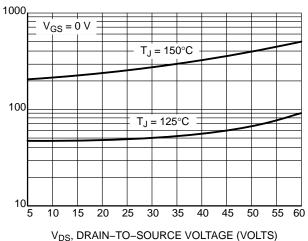


Figure 6. Drain-to-Source Leakage Current

vs. Voltage

TYPICAL PERFORMANCE CURVES

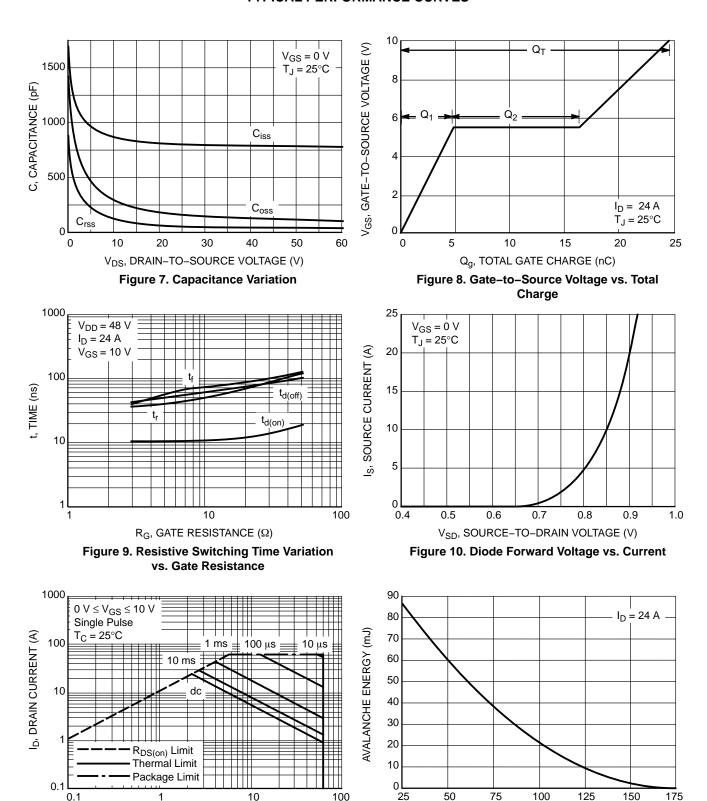


Figure 11. Maximum Rated Forward Biased Safe Operating Area

 V_{DS} , DRAIN-TO-SOURCE VOLTAGE (V)

Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

T_J, STARTING JUNCTION TEMPERATURE (°C)

TYPICAL PERFORMANCE CURVES

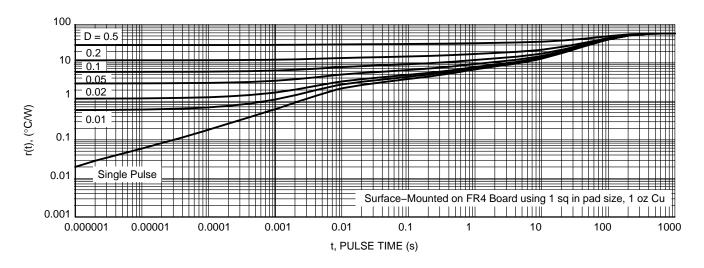


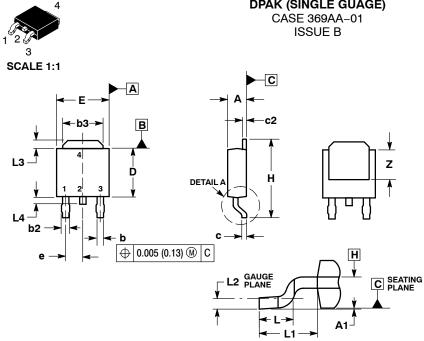
Figure 13. Thermal Response

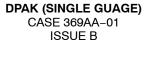
ORDERING INFORMATION

Device	Package	Shipping [†]
NTD5414NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NVD5414NT4G*	DPAK (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{*}NVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.





DETAIL A ROTATED 90° CW **DATE 03 JUN 2010**

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

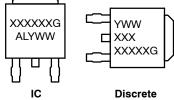
	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74 REF	
L2	0.020 BSC		0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

GENERIC

MARKING DIAGRAM*

STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE STYLE 1: PIN 1. BASE STYLE 2: PIN 1. GATE STYLE 3: PIN 1. ANODE 2. COLLECTOR 3. EMITTER 2. CATHODE 3. ANODE 2. DRAIN 3. SOURCE 4. COLLECTOR 4. DRAIN CATHODE STYLE 5: STYLE 6: STYLE 7: PIN 1. GATE 2. ANODE 3. CATHODE PIN 1. GATE 2. COLLECTOR PIN 1. MT1 2. MT2 3. GATE 3. EMITTER 4. ANODE COLLECTOR

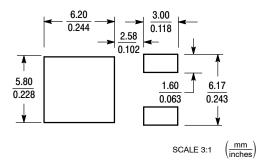
XXXXXXG



XXXXXX = Device Code Α = Assembly Location L = Wafer Lot ٧ = Year = Work Week WW = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DPAK (SINGLE GAUGE)		PAGE 1 OF 1	

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